PATENT

#10

MAR 2 4 2003 IN THE UT

For:

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Group Art Unit: 2624

Examiner: Not Assigned

Atty. Docket No. MIPFP005

Date: March 20, 2003 RECEIVED

MAR 2 6 2003

Technology Center 2600

CERTIFICATE OF MAILING
I hereby certify that this correspondence is being deposited with the United States Postal Service as First Class Mail in an envelope addressed to: Commissioner for Patents, Washington, DC 20231 on March 20, 2003.

arradi 1

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents Washington, DC 20231

Naoki KUWATA et al.

Filed: August 30, 2001

Application No. 09/941,711

IMAGE FILE

APPARATUS, METHOD, SIGNAL AND

CONFIGURED TO PROVIDE OUTPUT

COMPUTER PROGRAM PRODUCT

IMAGE ADJUSTMENT OF AN

Dear Sir:

The references listed in the attached PTO Form 1449, copies of which are attached, may be material to examination of the above-identified patent application. Applicants submit these references in compliance with their duty of disclosure pursuant to 37 CFR §§ 1.56 and 1.97. The Examiner is requested to consider these references and to acknowledge such consideration by initialing the attached PTO Form 1449 at the appropriate locations.

References L-P and References L-2-O-2 are in the Japanese language. The relevance of each of References L-P and each of References L-2-O-2 may be ascertained by reviewing the corresponding English language abstract (see References Q-U and References Q-2-T-2, respectively).

This Information Disclosure Statement (IDS) is being filed before the first Office Action on the merits. Accordingly, no fees are due in connection with the filing of this IDS. In the event it is determined that fees are due, the Commissioner is hereby authorized to charge such fees to Deposit Account 50-0805 (Order No. MIPFP005).

Respectfully submitted, MARTINE & PENILLA, LLP

Peter B. Martine Reg. No. 32,043

710 Lakeway Drive, Suite 170 Sunnyvale, CA 94085 Telephone: (408) 749-6900 Customer Number 25920

Form	1449 (Modified)	Atty Docket No: U.S.				
OIPE		MIPFP005	09/941,711			
(3)	Information Disclosure	Applicants:				
IAR 2 4 2003 12	Statement By Applicant	Naoki Kuwata et al.				
\$		Filing Date:	Group:			
Ya Tu alto	(Use Several Sheets if Necessary)	August 30, 2001	2624			

U.S. Patent Documents

Examiner						Sub-
Initial	No.	Patent No.	Date	Patentee	Class	class
	Α	6,273,535	8/2001	Inoue et al.		
	В					
	С					
	D				RECEI	VED
	E					
	F				MAR 2 6	2003
	G					mtor 2600
	Н				echnology Ce	ntel 2000
	J					
	K					

Foreign Patent or Published Foreign Patent Application

Examiner		Document	Publication	Country or		Sub-	Trans	lation
Initial	No.	No.	Date	Patent Office	Class	class	Yes	No
	L	06-008537	1/1994	Japan				Х
	М	09-219817	8/1997	Japan	_			X
	N	10-191246	7/1998	Japan				X
	0	11-088672	3/1999	Japan				X
	Р	11-127415	5/1999	Japan				X

Other Documents

Examiner		
Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
	Q	Abstract of Japanese Patent Pub. No. 06-008537, Pub. Date: January 18, 1994, Patent Abstracts of Japan
	R	Abstract of Japanese Patent Pub. No. 09-219817, Pub. Date: August 19, 1997, Patent Abstracts of Japan
	S	Abstract of Japanese Patent Pub. No. 10-191246, Pub. Date: July 21, 1998, Patent Abstracts of Japan
	Т	Abstract of Japanese Patent Pub. No. 11-088672, Pub. Date: March 3, 1999, Patent Abstracts of Japan
	U	Abstract of Japanese Patent Pub. No. 11-127415, Pub. Date: May 11, 1999, Patent Abstracts of Japan
Examiner	-	Date Considered

Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form 1449 (Modified)	Atty Docket No: U.S.			
() F 2)	MIPFP005	09/941,711		
Information Disclosure	Applicants:			
MAR 24 Statement By Applicant	Naoki Kuwata et al.			
\2 \ \(\bar{\varksigma} \).	Filing Date:	Group:		
(Use Several Sheets if Necessary)	August 30, 2001	2624		

U.S. Patent Documents

Examiner						Sub-
Initial	No.	Patent No.	Date	Patentee	Class	class
	A-2					
	B-2				DEC	EIVED
	C-2				NEO	
	D-2				MAR 2	6 2003
	E-2				,,,,	
	F-2				Technology	Center 2600
	G-2					
	H-2					
	I-2					
	J-2					
	K-2					

Foreign Patent or Published Foreign Patent Application

Examiner		Document	Publication	Country or		Sub-	Trans	lation
Initial	No.	No.	Date	Patent Office	Class	class	Yes	No
	L-2	11-331596	11/1999	Japan				Χ
	M-2	2000-013718	1/2000	Japan				Х
	N-2	2000-137806	5/2000	Japan				Х
	0-2	2001-147481	5/2001	Japan				Χ
	P-2							

Other Documents

Examiner		
Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
	Q-2	Abstract of Japanese Patent Pub. No. 11-331596, Pub. Date: November
		30, 1999, Patent Abstracts of Japan
	R-2	Abstract of Japanese Patent Pub. No. 2000-013718, Pub. Date: January
		14, 2000, Patent Abstracts of Japan
	S-2	Abstract of Japanese Patent Pub. No. 2000-137806, Pub. Date: May 16,
		2000, Patent Abstracts of Japan
	T-2	Abstract of Japanese Patent Pub. No. 2001-147481, Pub. Date: May 29,
		2001, Patent Abstracts of Japan
Examiner		Date Considered

Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.